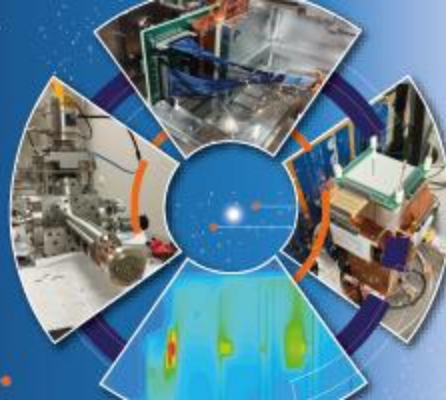


# Intégration des Détecteurs Semi-conducteurs

**Irène Joliot-Curie**  
Laboratoire de Physique des 2 Infinis

11-12 Juin 2026 Auditorium Joliot-Curie ORSAY - bât.100



## X-ray beam diagnostics at SOLEIL

*Détecteurs pour diagnostic du faisceau de rayons X à SOLEIL*

Journées Réseau Semiconducteurs 2026 – IJCLab Orsay

Marie ANDRÄ – on behalf of the Detector Group - SOLEIL

- SOLEIL synchrotron + a beamline
- What are X-ray diagnostics and why do we need them?
- Types of X-ray diagnostics at SOLEIL
  - Beam Imagers
  - Position Monitors
  - Intensity Monitors
- Future SOLEIL II & paths of X-ray diagnostics development at SOLEIL
  
- *Le synchrotron SOLEIL + une ligne de lumière*
- *Qu'est-ce qu'un "diagnostique du faisceau X" et pourquoi en avons-nous besoin?*
- *Types de diagnostics à SOLEIL*
  - *Imageurs faisceau*
  - *Moniteurs de position*
  - *Moniteurs d'intensité*
- *Développement de futurs diagnostics faisceau pour SOLEIL II*

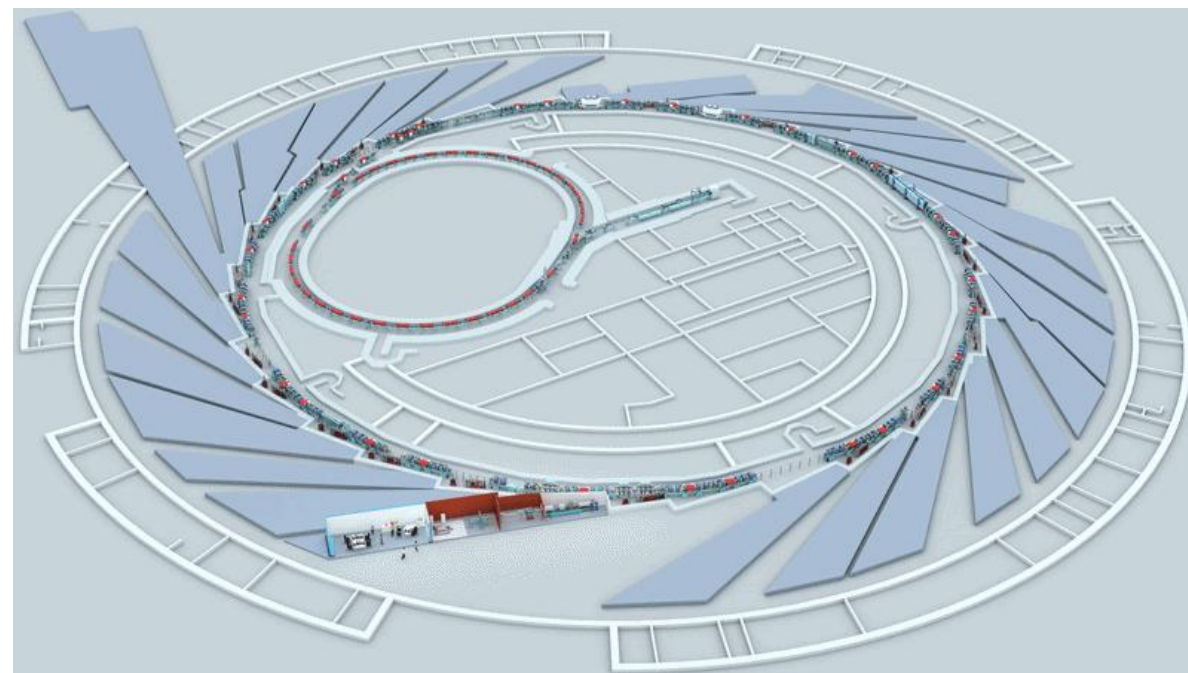
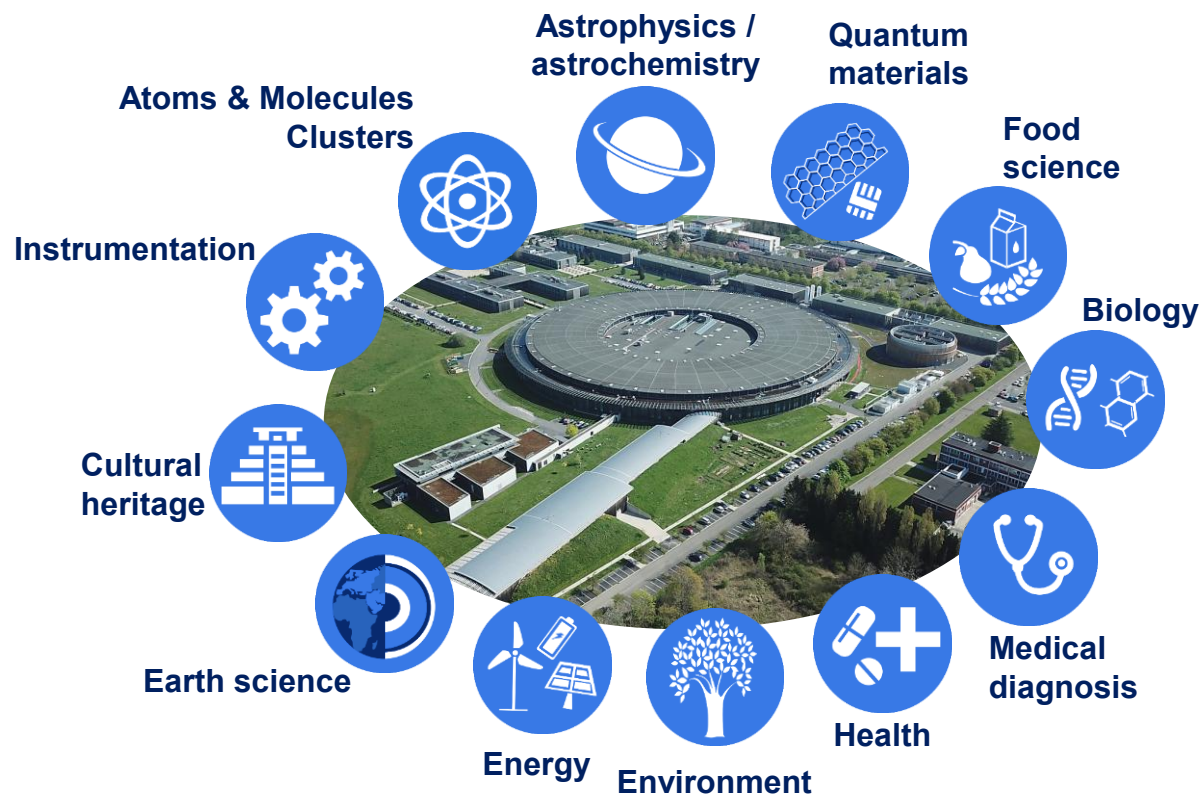
## Source Optimisée de Lumière d'Énergie Intermédiaire du LURE



~ 634 M€  
Construction budget  
(2002-2012)

~ 61 M€  
Annuel budget

72%   
28%

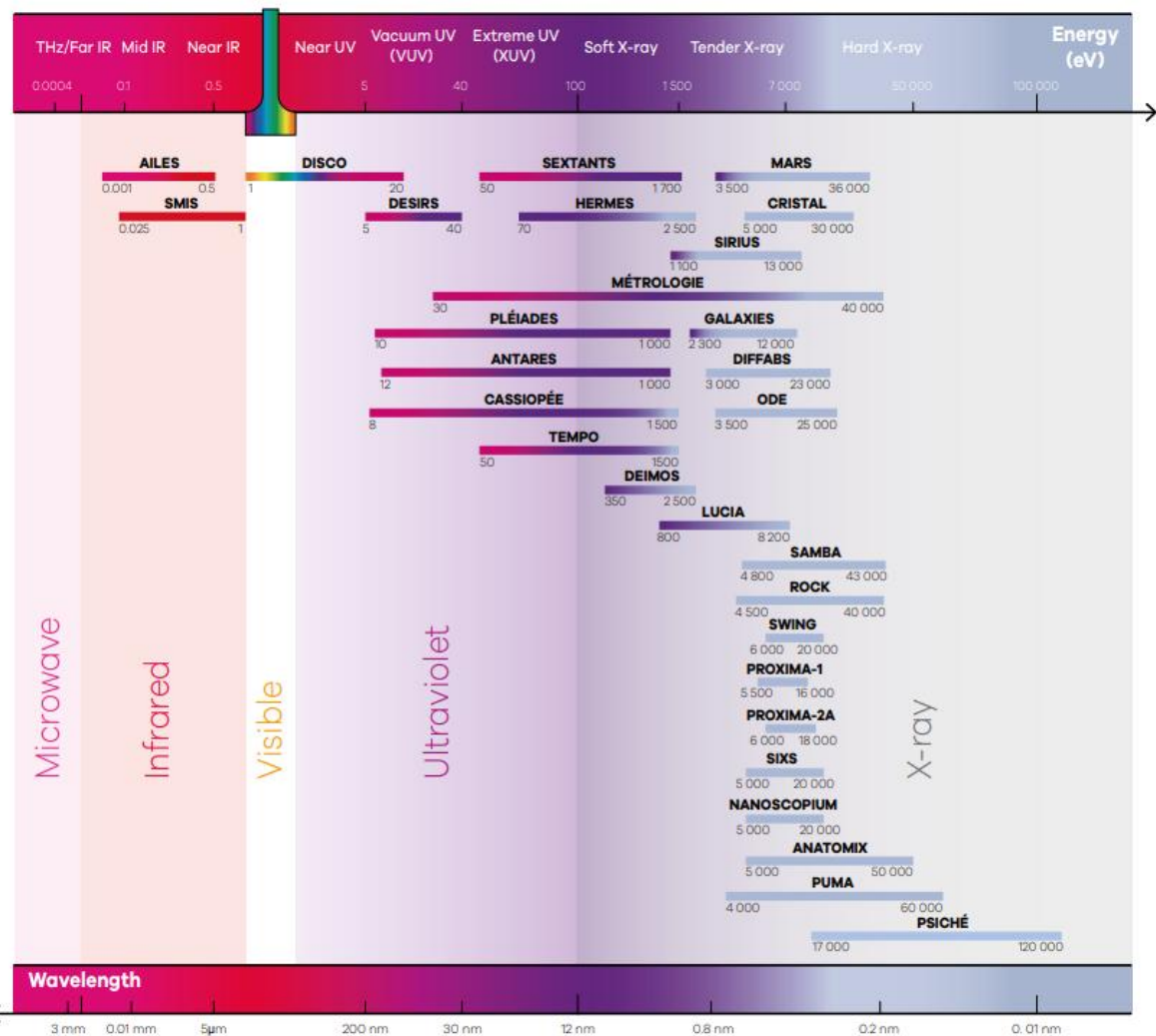


More info and apply for beamtime:  
[www.synchrotron-soleil.fr](http://www.synchrotron-soleil.fr)

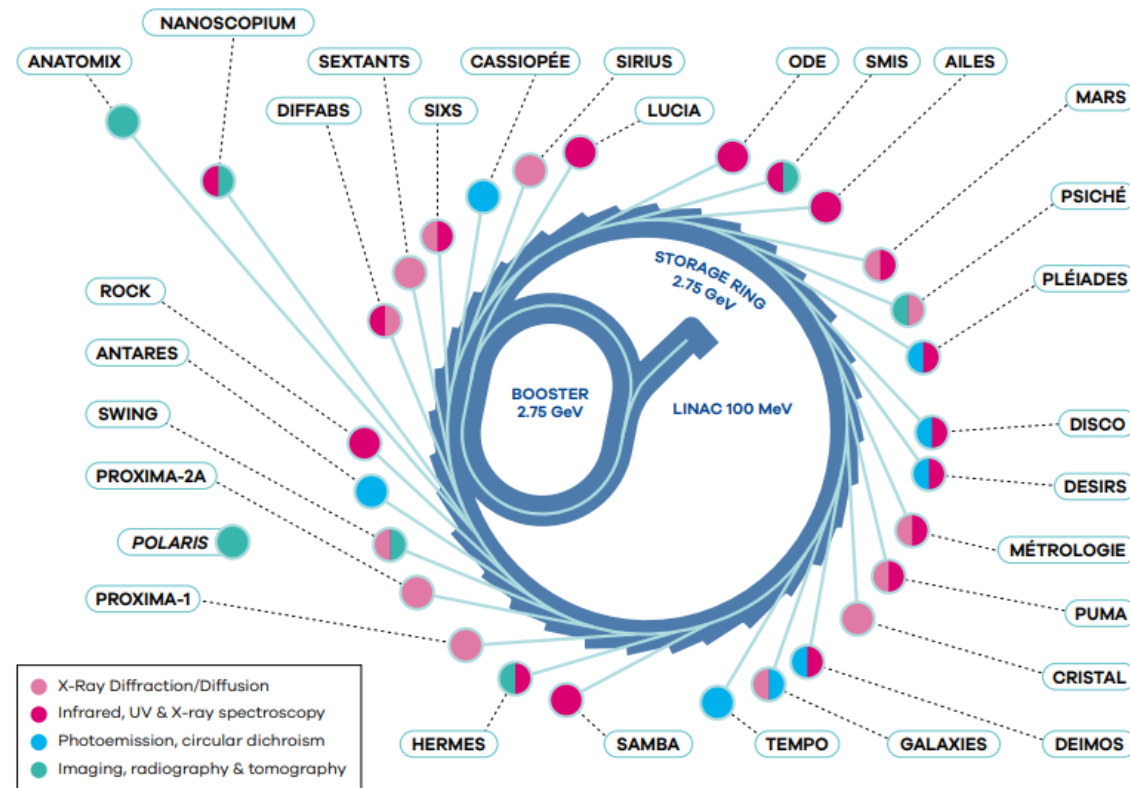
- French national synchrotron
- 29 beamlines
- Energies from 1 meV to 100 keV

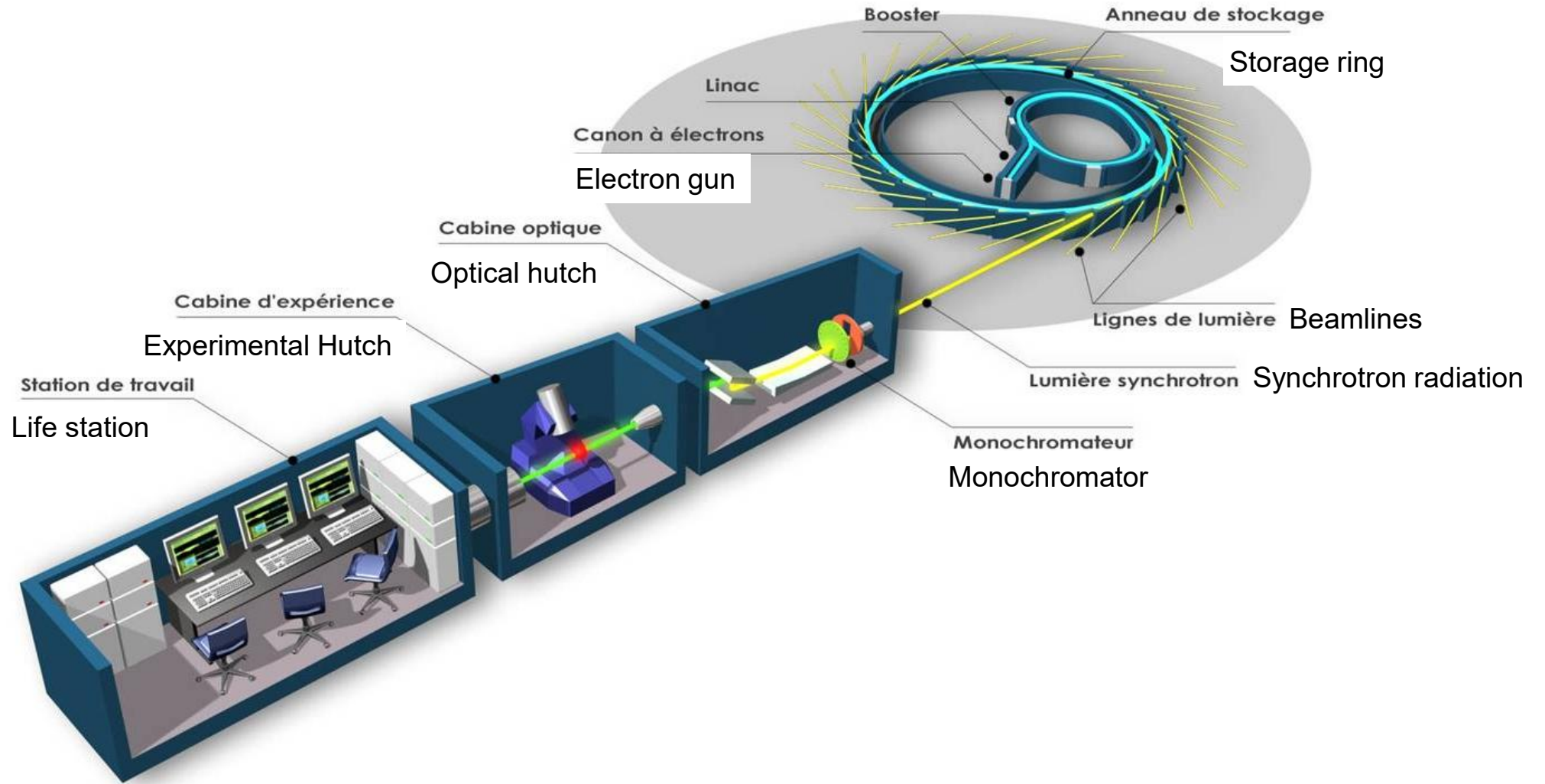
- *Synchrotron national français*
- *29 lignes de lumière*
- *Energies de 1 meV à 100 keV*

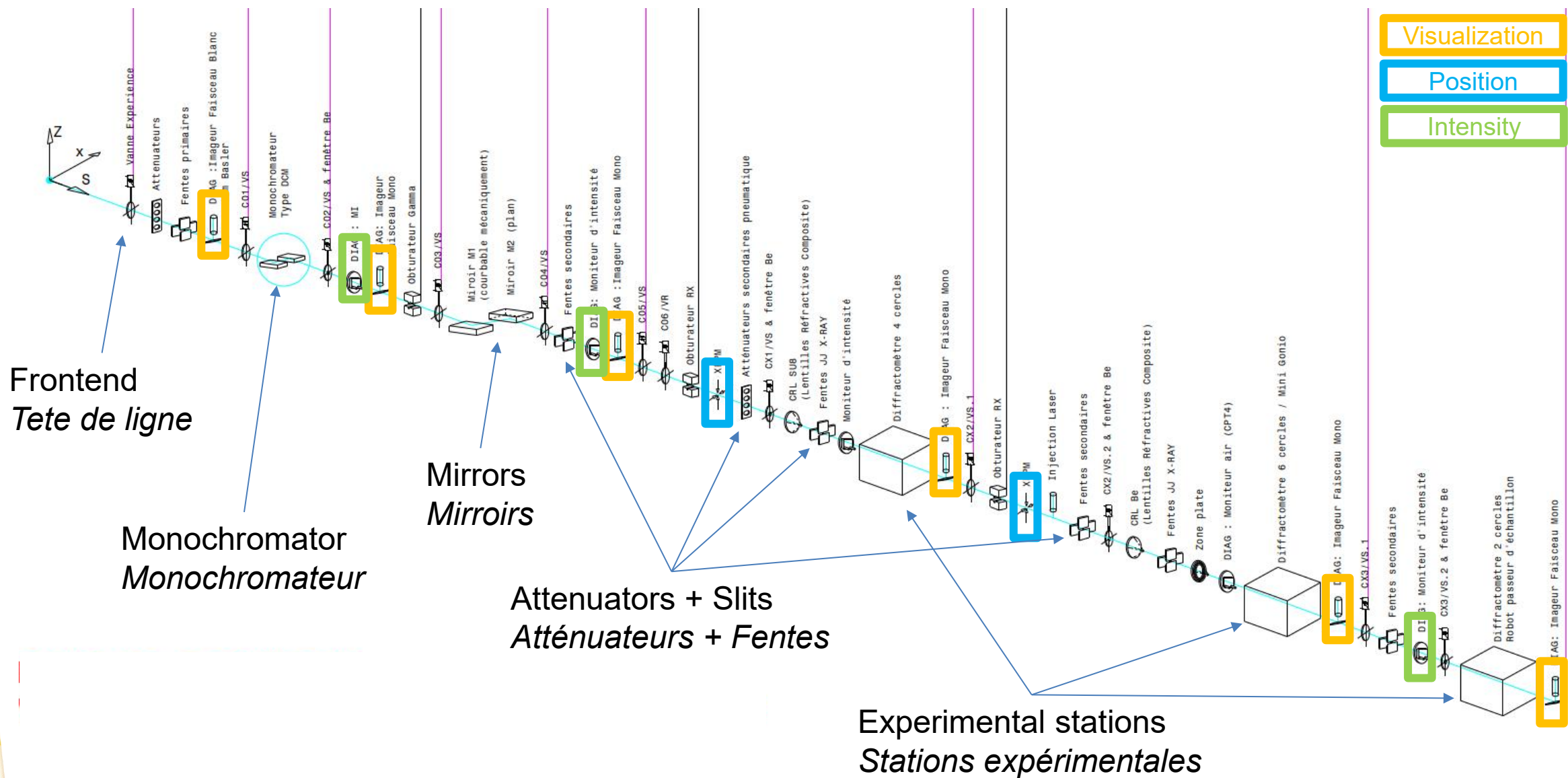
## BEAMLINE ENERGY RANGES



## ANALYTICAL TECHNIQUES

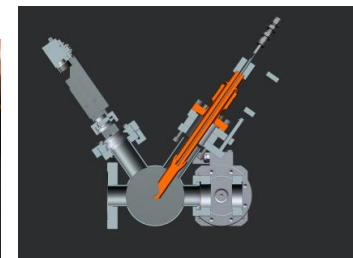
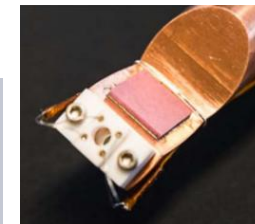
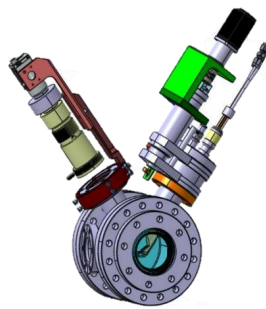
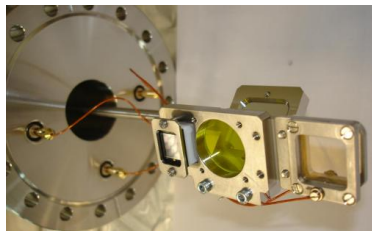
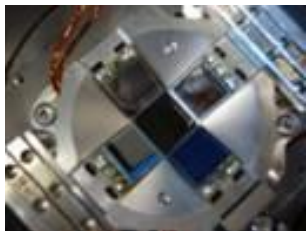
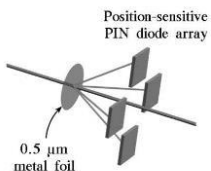
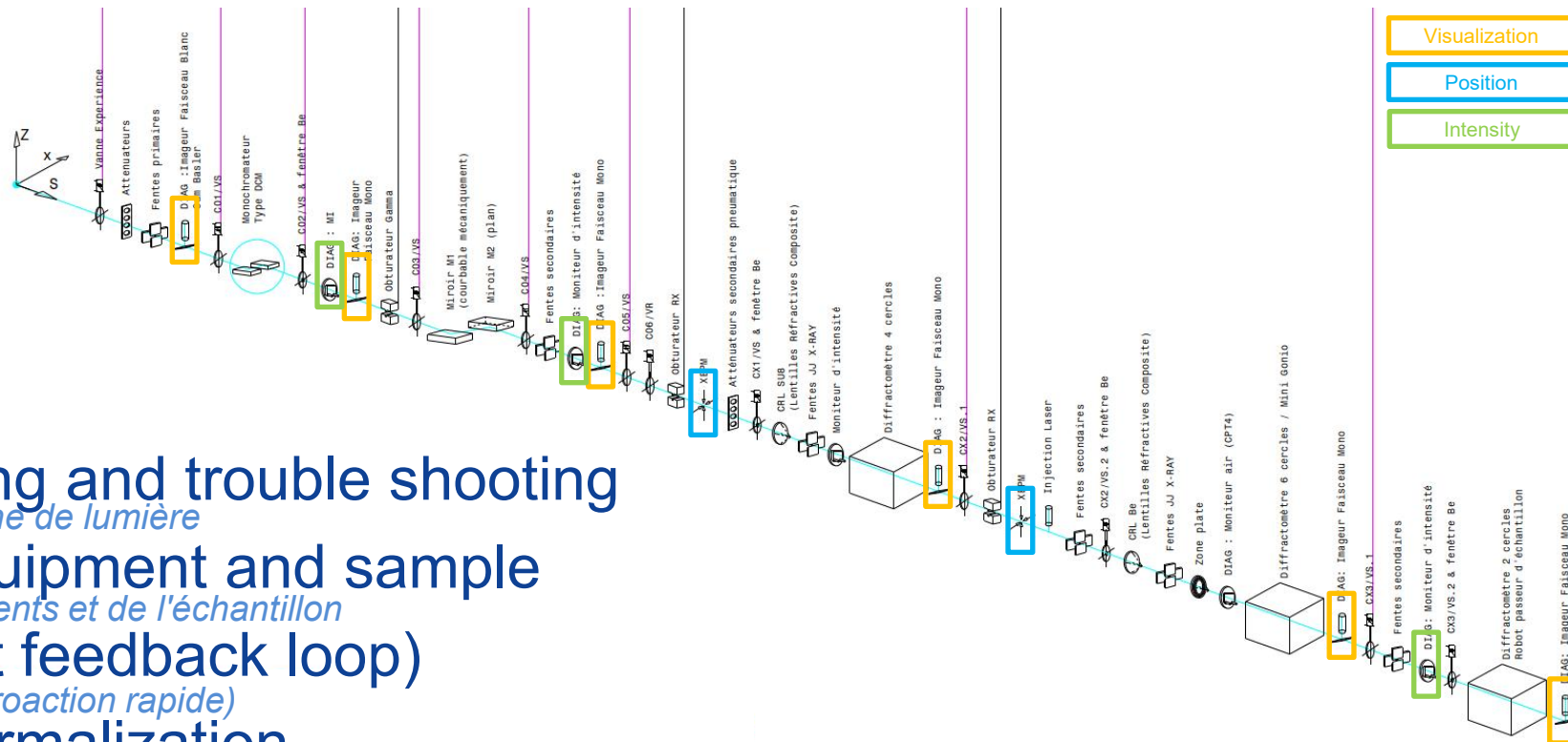




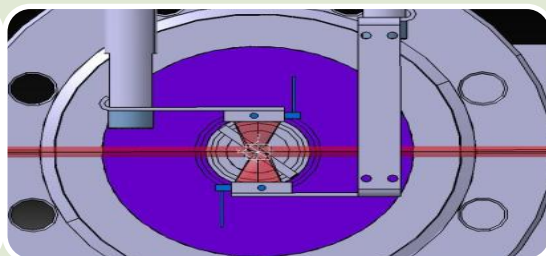


- **Beam visualization**  
*Visualisation du faisceau*
- **Position monitoring**  
*Surveillance de la position*
- **Intensity monitoring**  
*Surveillance de l'intensité*

- **Beamline commissioning and trouble shooting**  
*Mise en service et dépannage de la ligne de lumière*
- **Alignment of optics, equipment and sample**  
*Alignement des optiques, des équipements et de l'échantillon*
- **Beam stabilization (fast feedback loop)**  
*Stabilisation du faisceau (boucle de rétroaction rapide)*
- **Reference and data normalization**  
*Référence et normalisation des données*



C. Meneglier et al., Proc. MEDSI'18, Paris, France; Desjardins et al., JSR (2014) 21



## Beam imager

- (Multilayer +)  
Scintillator +  
camera

### *Imageurs faisceau*

- (Multi-couche +)  
scintillateur +  
caméra

## Intensity monitor

- Photodiodes,  
direct / scattering
- Gold mesh
- PMT, ion.  
Chamber

### *Moniteurs d'intensité*

- *Photo diodes,  
direct / diffusion*
- *Grille d'or*
- *Chambre  
d'ionisation*

## Position monitor

- Duolateral  
diamond PSD
- 4 Q-diode
- Alkire: fluo to 4  
diodes

### *Moniteur de position*

- *PSD diamant duo-  
latéral*
- *diodes 4Q*
- *Alkire : fluo vers 4  
diodes*

## Electronics

- Low current  
amplifiers

### *Electronique*

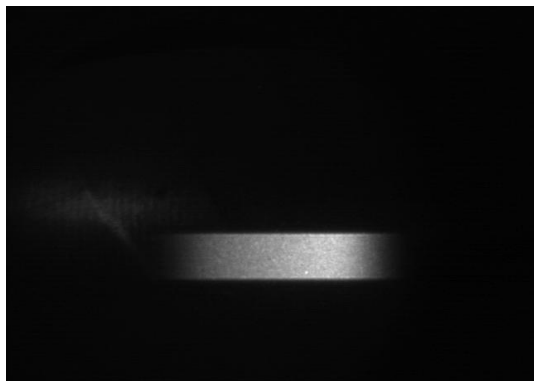
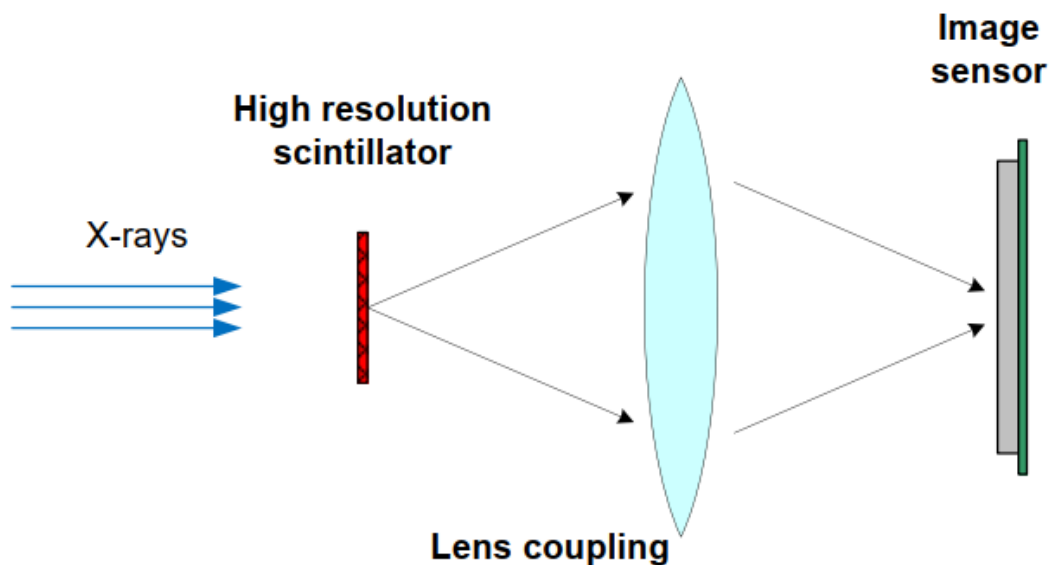
- *Amplificateurs à  
faible courant*

- Femto
- Locum
- Keithley
- Novelec
- Ontrac

# Beam Imagers

Imageurs faisceau





- Visualize the shape and profile of the beam

*Visualiser la forme et le profil du faisceau*

- Design constraints

*Contraintes de conception*

- Scintillator type

*Type de scintillateur*

- Optical resolution

*Résolution optique*

- Cooling

*Refroidissement*

- Mechanical design

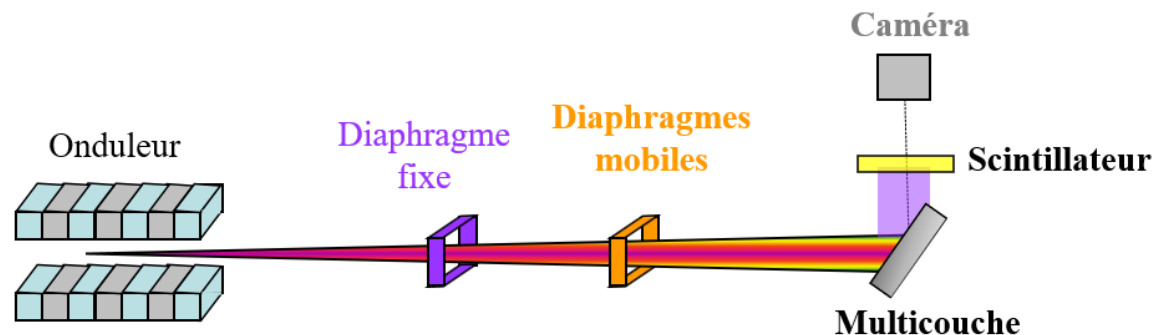
*Conception mécanique*

- Vacuum compatibility

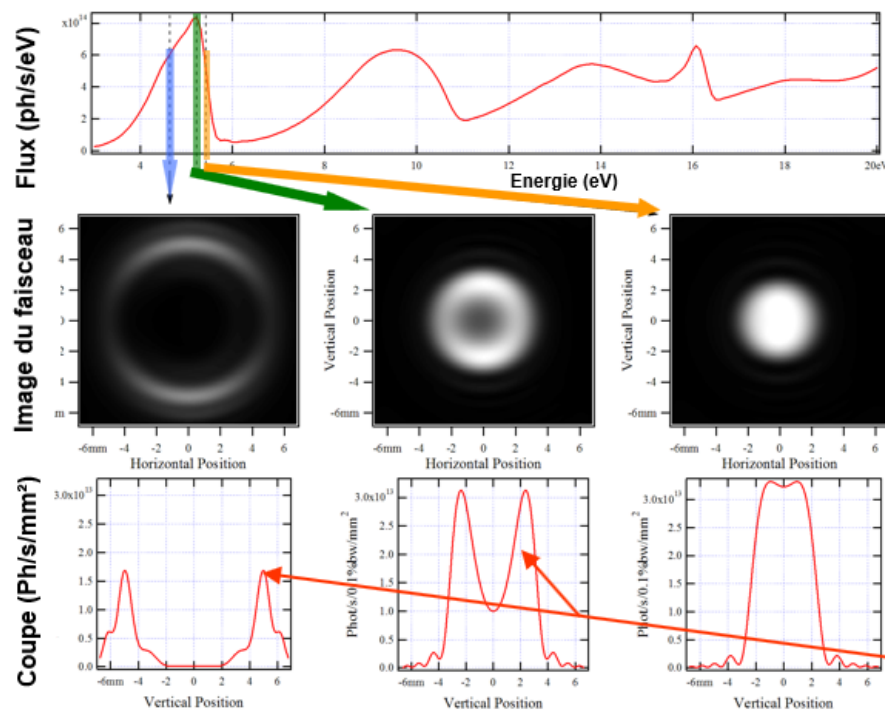
*Compatibilité avec le vide*

- Main purpose: **white** beam imager

- Undulators alignment
- Diaphragm alignment
- Undulator diagnostic



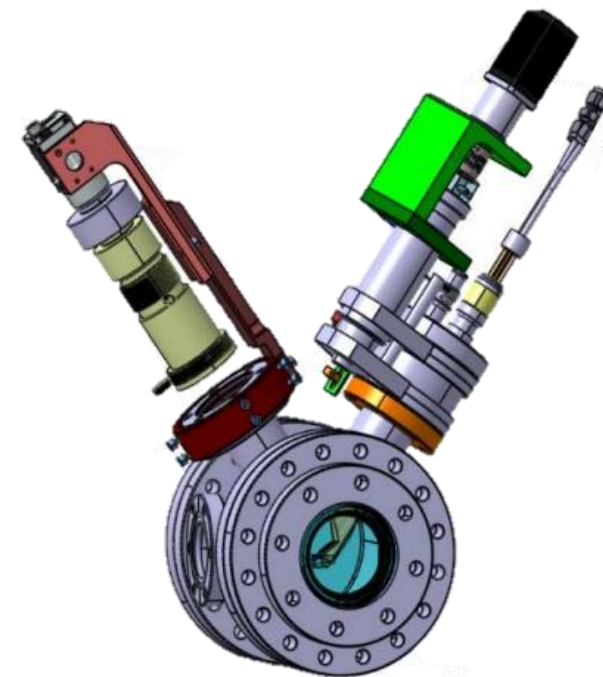
Flux en sortie de l'onduleur HU640 de la ligne DESIR (Simulé par O. Chubar)



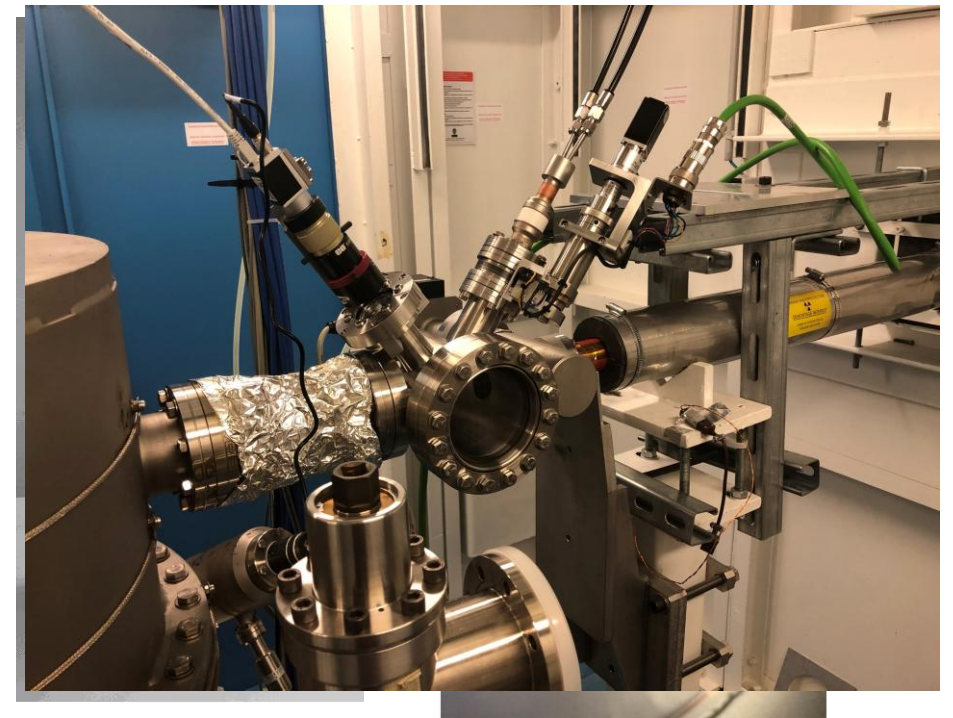
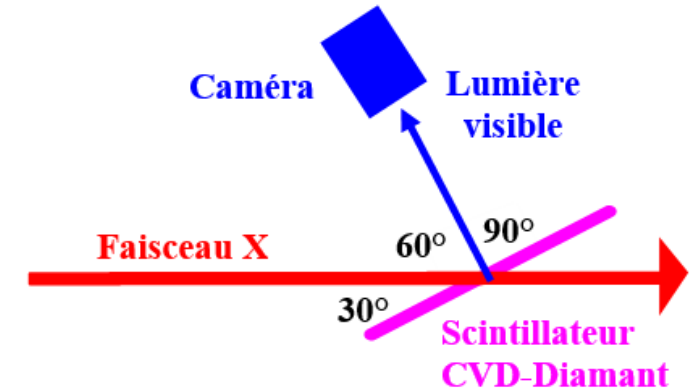
Spectre d'émission de l'onduleur

Image du faisceau après sélection d'une énergie

Définition de l'axe de propagation du faisceau de l'onduleur



- **Ceramic:** Designed for hard & soft Xray beamlines (undulator & BM)  
*pour lignes X durs et mous*
- **Diamond:** Designed for hard Xray white beam, undulator sources  
*pour lignes X durs, faisceau blanc, sources onduleur*
- **YAG:Ce / LuAG:Ce / YAP:Ce:** Designed for monochromatic hard & soft Xray  
*pour faisceau monochromatique, X durs et mous*

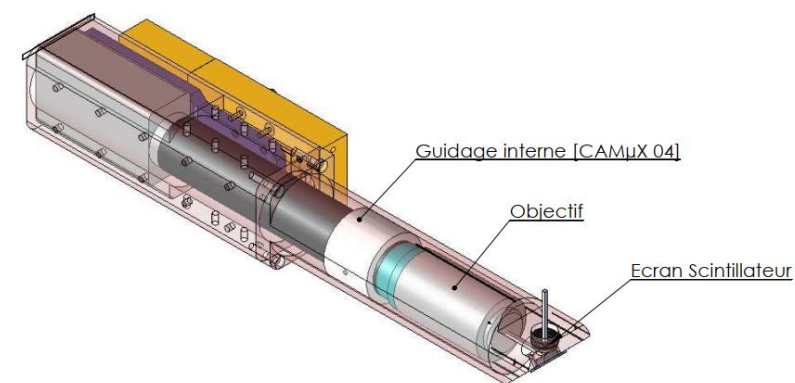
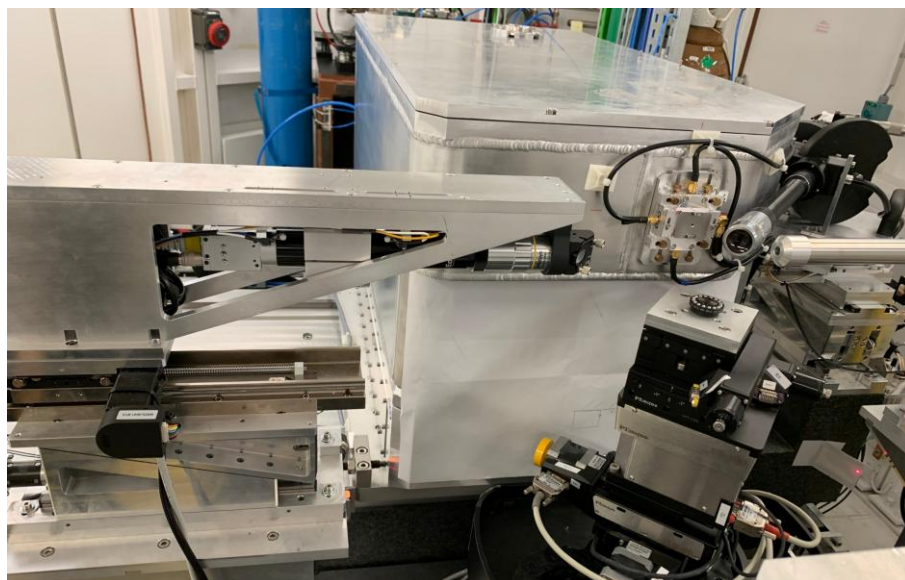
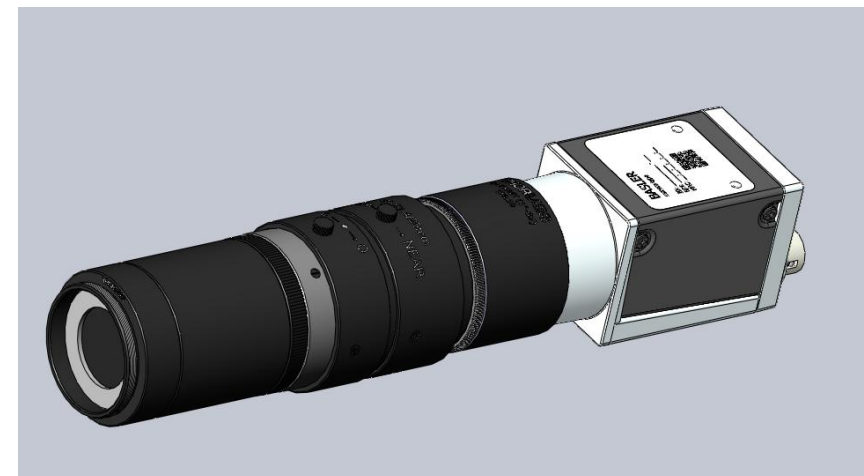


Scintillator	Beam <i>Faisceau</i>	Power <i>Puissance</i> [W]	dP [W/mm <sup>2</sup> ]	Dimension
Ceramic	white	343	1	Few cm <sup>2</sup>
Ceramic	pink	30	30	1 mm <sup>2</sup>
YAG:Ce	mono.	< 1	< 1	mm <sup>2</sup> to cm <sup>2</sup>
Diamond	white	90	72	1.5 x 0.8 mm <sup>2</sup>

- Designed for beam size  $< \text{mm}^2$ , hard Xray

*Conçu pour des faisceaux de taille  $< \text{mm}^2$ , rayons X durs*

Optical characteristics	
Scintillator	Clear polished YAG:Ce / LuAG:Ce 20 $\mu\text{m}$ thick
Résolution	$< 1 \mu\text{m}$
Optical magnification	x0,5 to x20



# Position Monitors

Moniteurs de position

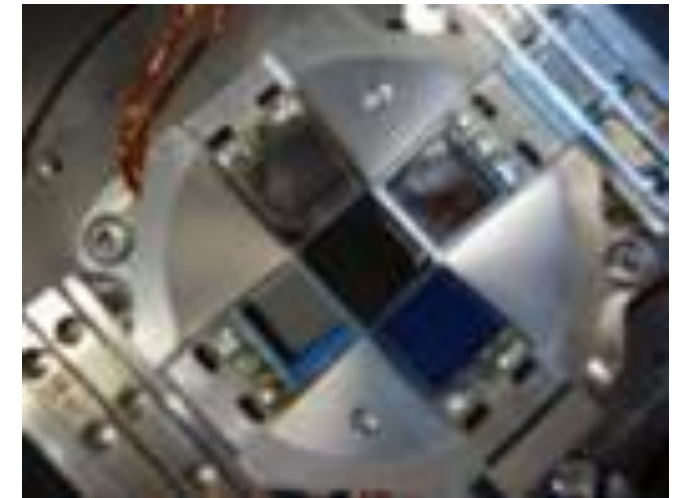
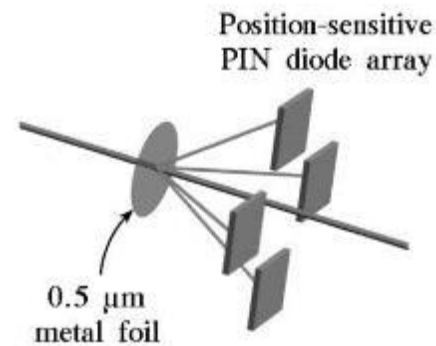
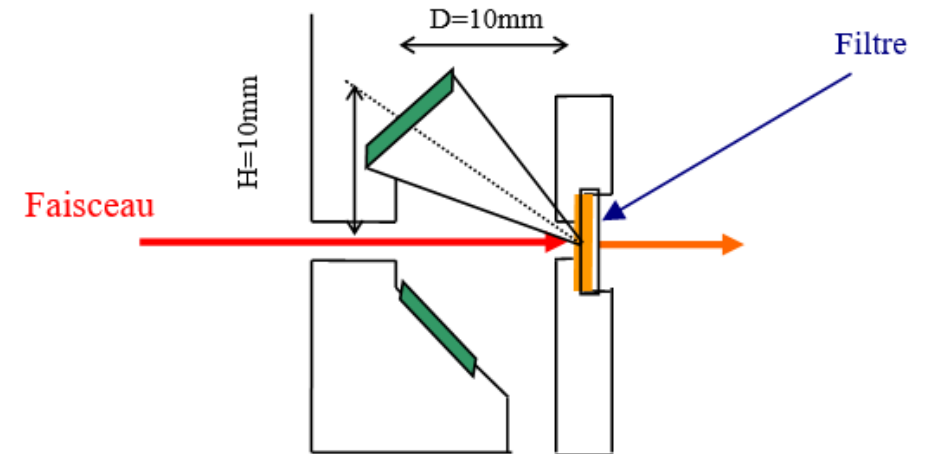


## Indirect detection

- Scatterer (e.g. Kapton foil) + 4 photo diodes
  - Alkire design
- + low current amplifier + electronics for readout

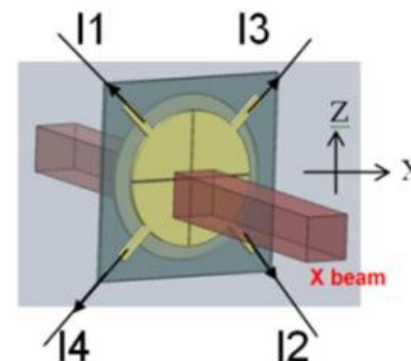
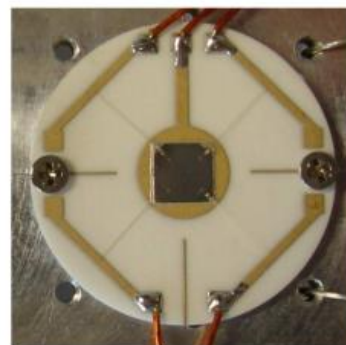
## Détection indirecte

- *Diffuseur (p.ex., feuille de Kapton) + 4 photodiodes*
  - *Conception d'Alkire*
- + *amplificateur de faibles courants + électronique de lecture*

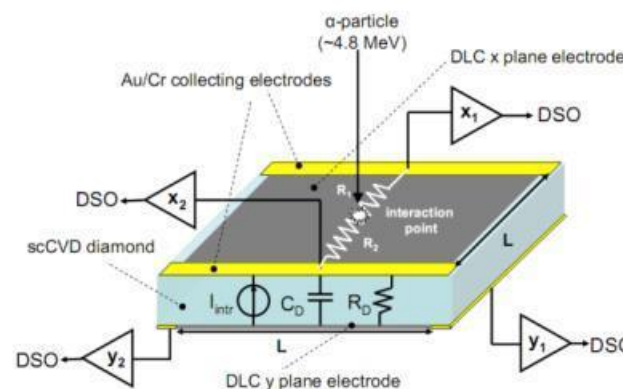


## Direct detection

- Silicon or diamond or SiC
- 4 Quadrant design



- Duo-lateral / resistive design



# Intensity Monitors

Moniteurs d'intensité



- Direct measurement

- Photodiode
- Diamond
- (PSD)

- Scattering / fluo. measurement

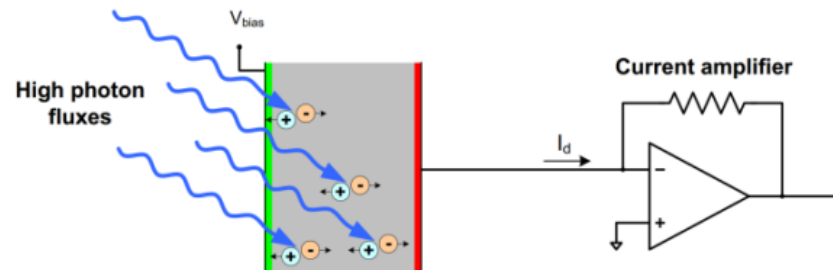
- Foil + photodiode
- (QBPM)

- *Mesure directe*

- *Photodiode*
- *Diamant*
- *(PSD)*

- *Mesure par diffusion / fluorescence*

- *Feuille + photodiode*
- *(QBPM)*



- Readout current electrometer

- *Femto* current to voltage amplifier
  - Digitalisation
- *Keithley 486* current monitor

- ~100 devices

- At all beamlines

- *Électromètre à lecture de courant*

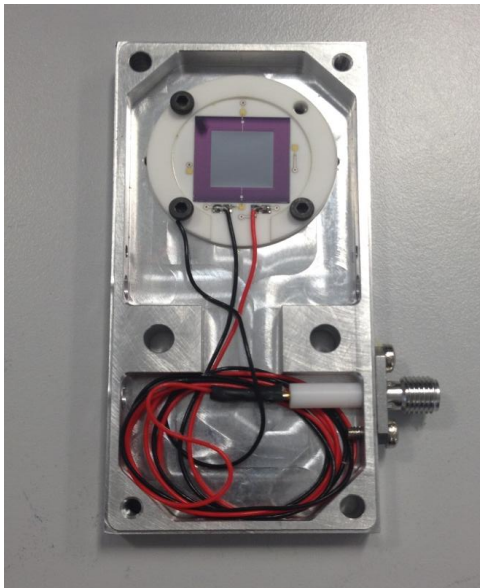
- *Amplificateur à transimpédance Femto*
  - *Numérisation*
- *Moniteur de courant Keithley 486*

- ~100 appareils

- *Sur toutes les lignes de lumière*

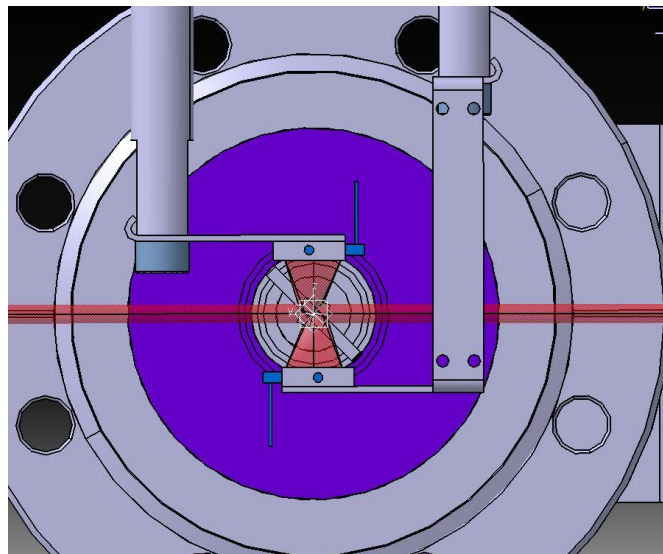
## Direct photo diode

*Diode photoélectrique directe*



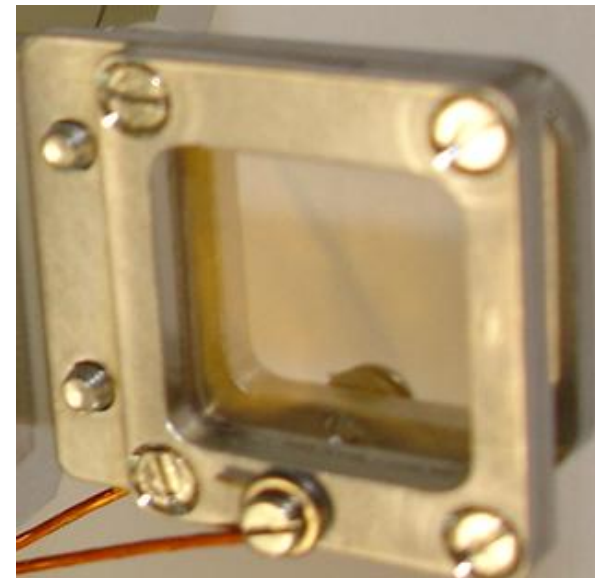
## Scattering

*Diffusion*



## Gold mesh (for soft X-rays)

*Grille d'or (pour X mou)*

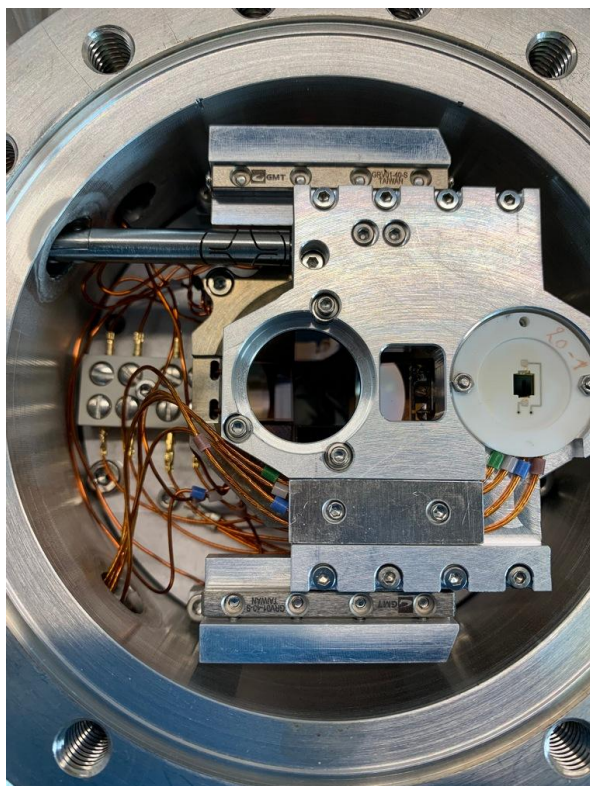


+ readout electronics (e.g. Keithley)

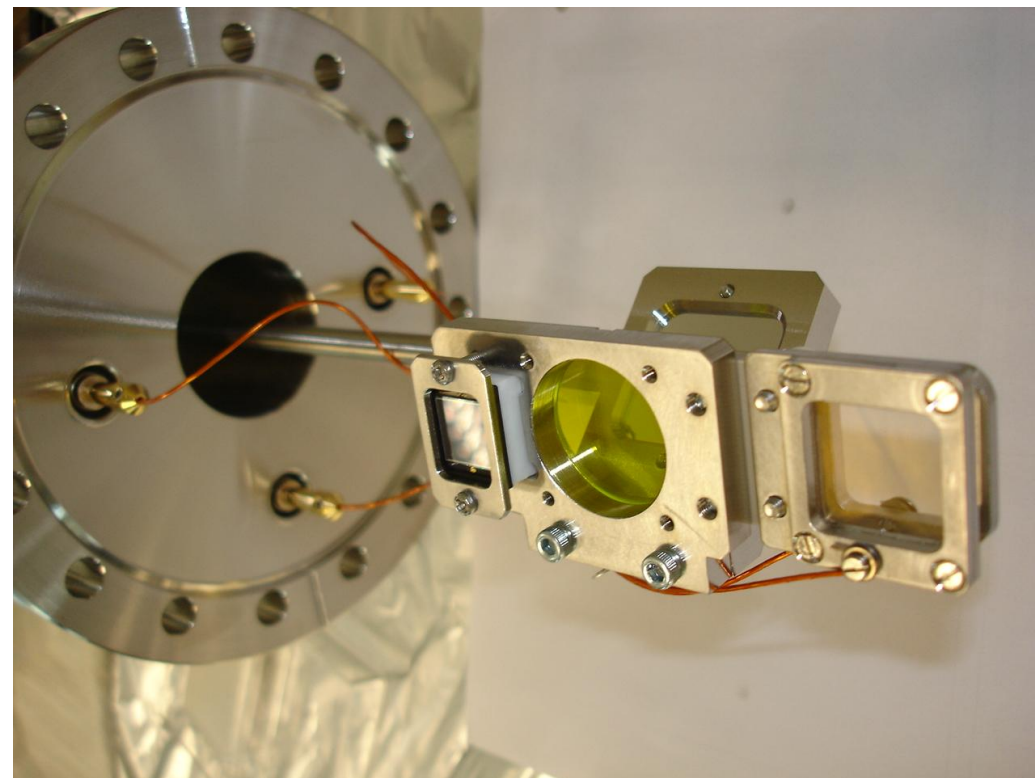
+ électronique de lecture (p.ex., Keithley)

- Ionisation Chamber
- Current on mirrors
- Frankenstein's Monsters

**QBPM + PSD Diamond**



**PYG : Photodiode / YAG / Gold mesh**





From  to   
Roadmap & Developments

**What for?** Monitor the beam's intensity, position & shape  
 → for equipment & sample alignment,  
 reference & data normalization

*Pourquoi?* Surveiller l'intensité, la position et la forme du faisceau  
 → pour l'alignement de l'équipement et de l'échantillon, pour  
 références et pour normaliser les données



### Today / Aujourd'hui

- 368 devices installed
- 13 different types, highly customized

Beam imager  
 Beam position  
 Intensity monitor

Matching electronics



### Goal / Objectif

- Few default systems
- Easy to manage & maintain
- Ensure flexibility

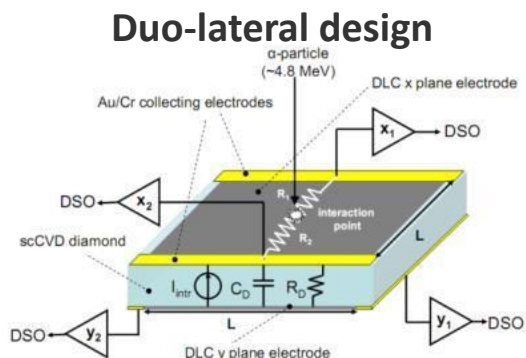
49 new + 90 updated  
 diagnostics to be installed

New developments  
 required for soft X-rays +  
 spatial resolution

### Roadmap:

Keep review drop new  
**368** diagnostics devices: **266** + **90** - **12** + **49** → **405**  
 Ca **1 M€** and **3** developments

## Thin Diamond rXBPM

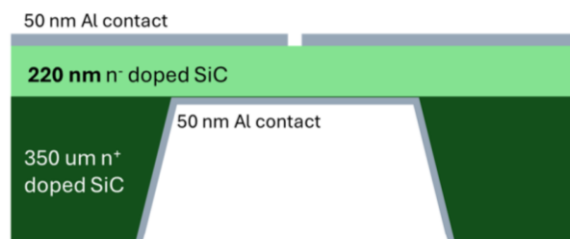


- 12 + 14 new devices on 18 beamlines
- Need to reproduce **3-5  $\mu\text{m}$  thin** rXBPMs
- Master resistive carbon deposition
- C2N, CINEL, CEA, Lumin, BNL, DiamFab

Desjardins et al, JSR (2014) 21



## SiC (r)XBPM + Electronics



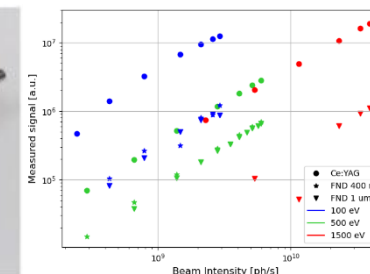
- Radiation hard
- Testing 220nm thin membranes with 4Q or rXBPMs by SENSIC<sup>CH</sup>
- Combined with (fast feedback) **electronics** from STLAB

Trovato et al. (2025), JACoW, 14<sup>th</sup> IBIC



## FIBIEX

FND-based in-situ beam imager for EUV and soft X-rays



- Based on fluorescent nanodiamonds
- Semi-transparent for soft X-rays
- Thin electrospayed layers
- Negligible afterglow



中央研究院 原子與分子科學研究所  
Institute of Atomic and Molecular Sciences, Academia Sinica



Y. Y. Hui et al., RSC Adv., 2025, 15, 1011-1019

H.-C. Lu et al., 2020, ACS Appl Mater Interfaces, 12, 3

Await funding

